Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/619,446	MALEVILLE, CHRISTOPHE	
Examiner	Art Unit	
Binh X. Tran	1765	

SEADOUED						
	SEARCHED					
Class	Subclass	Date	Examiner			
438	455	9/14/2005	ВТ			
216	, 20	9/14/2005	ВТ			
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INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		
			-		

SEARCH NOT (INCLUDING SEARCH		)
	DATE	EXMR
Search keywords and inventor's name using USPAT, USPG-PUB, JPO, EPO, DERWENT database	9/14/2005	ВТ